

Features

- Low $R_{DS(ON)}$
- Green Device Available
- 100% EAS Tested
- Advanced Trench MOS Technology

Applications

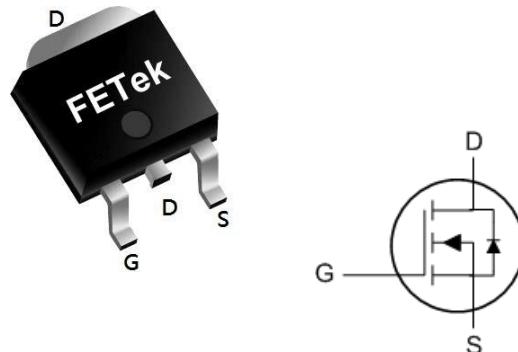
- Power Management in TV Converter.
- DC/DC Converter.

Product Summary



BVDSS	RDS(on)	ID
150V	56mΩ	23A

TO252 Pin Configuration



Absolute Maximum Ratings

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	150	V
V_{GS}	Gate-Source Voltage	± 20	V
$I_D @ T_c = 25^\circ C$	Continuous Drain Current ¹	23	A
$I_D @ T_c = 100^\circ C$	Continuous Drain Current ¹	16	A
$I_D @ T_A = 25^\circ C$	Continuous Drain Current ¹	4.5	A
$I_D @ T_A = 70^\circ C$	Continuous Drain Current ¹	3.8	A
I_{DM}	Pulsed Drain Current ²	60	A
EAS	Single Pulse Avalanche Energy ³	61	mJ
I_{AS}	Avalanche Current	35	A
$P_D @ T_c = 25^\circ C$	Total Power Dissipation ⁴	72.6	W
$P_D @ T_A = 25^\circ C$	Total Power Dissipation ⁴	2.7	W
T _{STG}	Storage Temperature Range	-55 to 175	°C
T _J	Operating Junction Temperature Range	-55 to 175	°C

Thermal Data

Symbol	Parameter	Typ.	Max.	Unit
R _{θJA}	Thermal Resistance Junction-ambient ¹	---	55	°C/W
R _{θJC}	Thermal Resistance Junction-Case ¹	---	2.0	°C/W



FETek Technology Corp.

FKD20N15S

N-Ch 150V Fast Switching MOSFETs

Electrical Characteristics ($T_J=25^\circ C$, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=250\mu A$	150	---	---	V
$R_{DS(ON)}$	Static Drain-Source On-Resistance ²	$V_{GS}=10V, I_D=10A$	---	47	56	$m\Omega$
	Static Drain-Source On-Resistance ²	$V_{GS}=4.5V, I_D=10A$	---	53	70	$m\Omega$
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS}=V_{DS}, I_D=250\mu A$	1.2	---	2.5	V
I_{DSS}	Drain-Source Leakage Current	$V_{DS}=120V, V_{GS}=0V, T_J=25^\circ C$	---	---	1	μA
		$V_{DS}=120V, V_{GS}=0V, T_J=55^\circ C$	---	---	5	
I_{GSS}	Gate-Source Leakage Current	$V_{GS}=\pm 20V, V_{DS}=0V$	---	---	± 100	nA
g_{fs}	Forward Transconductance	$V_{DS}=5V, I_D=10A$	---	25	---	S
Q_g	Total Gate Charge	$V_{DS}=75V, V_{GS}=10V, I_D=10A$	---	19	---	nC
Q_{gs}	Gate-Source Charge		---	4.5	---	
Q_{gd}	Gate-Drain Charge		---	2.6	---	
$T_{d(on)}$	Turn-On Delay Time	$V_{DD}=75V, V_{GS}=10V, R_G=3.3\Omega$	---	18	---	ns
T_r	Rise Time		---	5.8	---	
$T_{d(off)}$	Turn-Off Delay Time		---	26.5	---	
T_f	Fall Time		---	4.5	---	
C_{iss}	Input Capacitance	$V_{DS}=25V, V_{GS}=0V, f=1MHz$	---	1090	---	pF
C_{oss}	Output Capacitance		---	93	---	
C_{rss}	Reverse Transfer Capacitance		---	6	---	

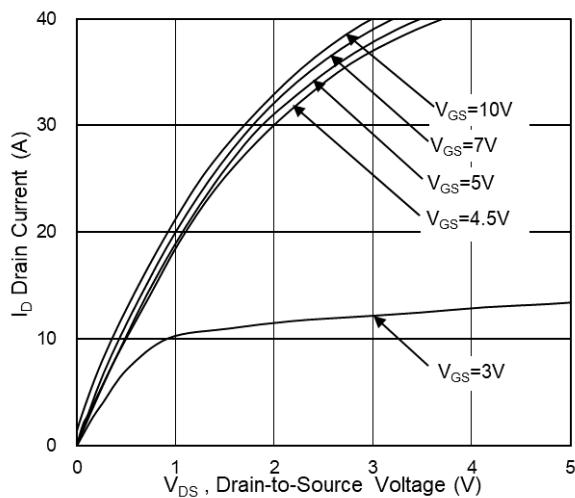
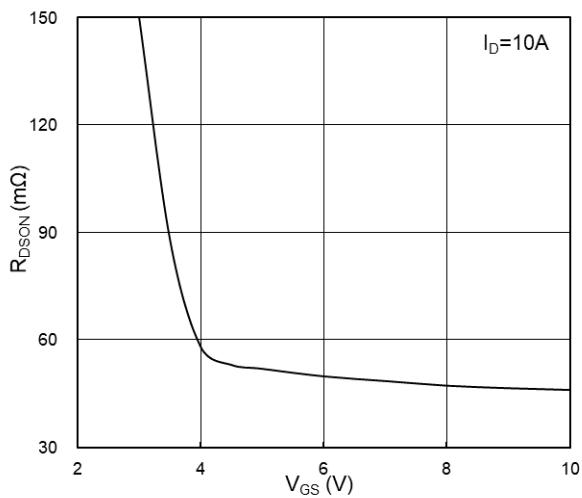
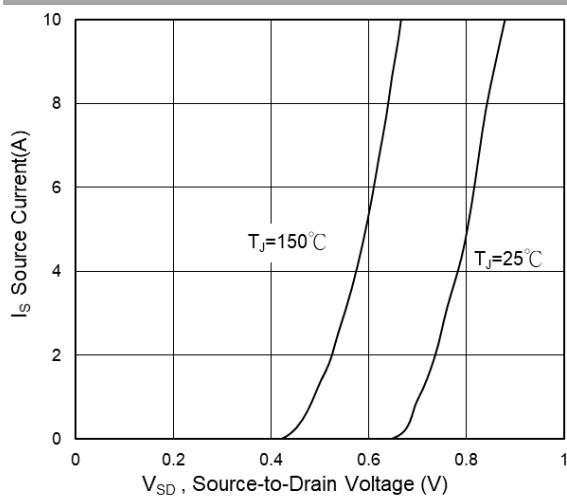
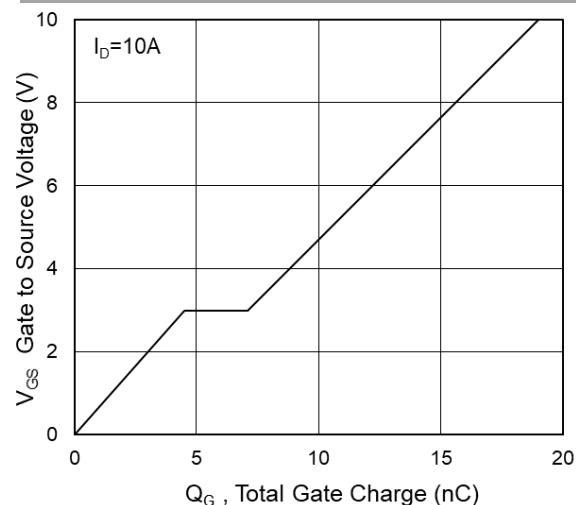
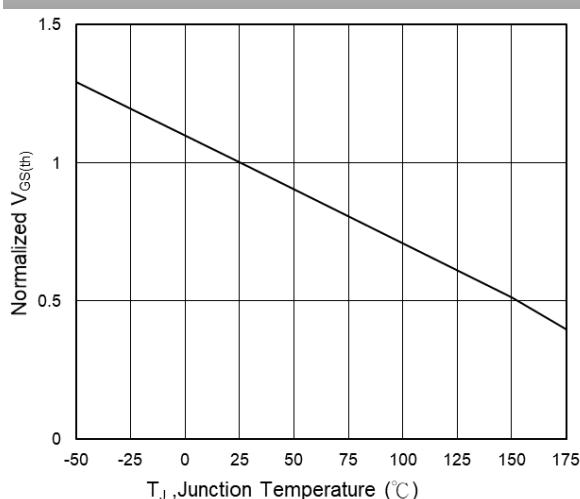
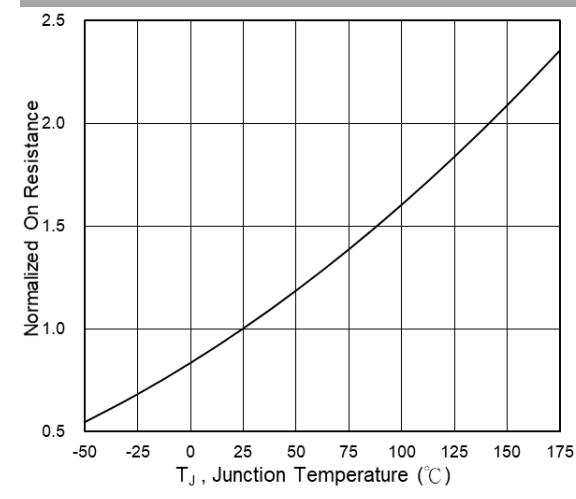
Diode Characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
I_s	Continuous Source Current ^{1,5}	$V_G=V_D=0V$, Force Current	---	---	20	A
V_{SD}	Diode Forward Voltage ²	$V_{GS}=0V, I_s=1A, T_J=25^\circ C$	---	---	1.2	V
t_{rr}	Reverse Recovery Time	$I_F=10A, dI/dt=100A/\mu s, T_J=25^\circ C$	---	45	---	nS
	Reverse Recovery Charge		---	138	---	nC

Note :

- 1.The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- 2.The data tested by pulsed , pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$
3. The EAS data shows Max. rating . The test condition is $V_{DD}=25V, V_{GS}=10V, L=0.1mH, I_{AS}=35A$
- 4.The power dissipation is limited by $150^\circ C$ junction temperature
- 5.The data is theoretically the same as I_D and I_{DM} , in real applications , should be limited by total power dissipation.

Typical Characteristics


Fig.1 Typical Output Characteristics

Fig.2 On-Resistance vs G-S Voltage

Fig.3 Source Drain Forward Characteristics

Fig.4 Gate-Charge Characteristics

Fig.5 Normalized $V_{GS(th)}$ vs T_J

Fig.6 Normalized $R_{DS(on)}$ vs T_J

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